## Application/Control No. Applicant(s)/Patent Under Reexamination 10/807,374 OTA, YUTAKA Notice of References Cited Examiner Art Unit Page 1 of 1 Songwei Qian 2109 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,091,896 A 07-2000 Α Curreri et al. 717/125 06-2001 В US-6,247,174 B1 Santhanam et al. 717/154 US-2002/0019973 A1 02-2002 Hayashida, Seiji С 717/106 US-D Ε US-US-F US-G US-Н USı US-J US-Κ US-L US-**FOREIGN PATENT DOCUMENTS**

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